

Notice of References Cited	Application/Control No. 10/782,421	Applicant(s)/Patent Under Reexamination KIM ET AL.	
	Examiner John D. Lee <i>John D. Lee</i>	Art Unit 2874	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,690,499	09-1987	Taylor et al.	385/111
*	B	US-4,846,566	07-1989	Barnett et al.	385/109
*	C	US-5,274,726	12-1993	Rawlyk et al.	385/109
*	D	US-6,697,556	02-2004	Militaru et al.	385/100
	E	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 00/77552 A1	12-2000	WIPO (PCT)	Staschewski	G02B 06/44
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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